MOSFET, N-Channel, POWERTRENCH®

40 V, 18.6 A, 4.5 m Ω

FDS8840NZ

General Description

The FDS8840NZ has been designed to minimize losses in power conversion application. Advancements in both silicon and package technologies have been combined to offer the lowest $r_{DS(on)}$ while maintaining excellent switching performance.

Features

- Max $r_{DS(on)} = 4.5 \text{ m}\Omega$ at $V_{GS} = 10 \text{ V}$, $I_D = 18.6 \text{ A}$
- Max $r_{DS(on)} = 6.0 \text{ m}\Omega$ at $V_{GS} = 4.5 \text{ V}$, $I_D = 14.9 \text{ A}$
- HBM ESD Protection Level of 6 kV Typical (Note 3)
- High Performance Trench Technology for Extremely Low r_{DS(on)} and Fast Switching
- High Power and Current Handling Capability
- These Devices are Pb–Free, Halogen Free/BFR Free and are RoHS Compliant

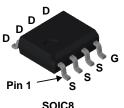
Applications

- Synchronous Buck for Vcore and Server
- Notebook Battery Pack
- Load Switch



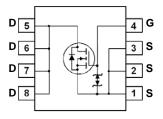
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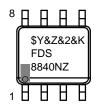


SOIC8 CASE 751EB

PIN ASSIGNMENT



MARKING DIAGRAM



\$Y = ON Semiconductor Logo &Z = Assembly Plant Code &2 = Numeric Date Code &K = Lot Code

FDS8840NZ = Specific Device Code

ORDERING INFORMATION

See detailed ordering and shipping information on page 2 of this data sheet.

ORDERING INFORMATION

Part Number	Device Marking	Package	Shipping [†]
FDS8840NZ	FDS8840NZ	SOIC8 (Pb-Free / Halogen Free)	2500 Units / Tape & Reel

[†]For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specification Brochure, BRD8011/D.

ABSOLUTE MAXIMUM RATINGS (T_A = 25°C unless otherwise noted)

Symbol	Parameter	Value	Unit
V _{DS}	Drain to Source Voltage	40	V
V_{GS}	Gate to Source Voltage	±20	V
I _D	Drain Current Continuous	18.6	Α
	Drain Current Pulsed	63	
E _{AS}	Single Pulse Avalanche Energy (Note 4)	600	mJ
P _D	Power Dissipation, T _A = 25°C (Note 1a)	2.5	W
	Power Dissipation, T _A = 25°C (Note 1b)	1.0	
T _J , T _{STG}	Operating and Storage Junction Temperature Range	-55 to 150	°C

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

THERMAL CHARACTERISTICS

Symbol	Parameter	Value	Unit	
$R_{ heta JC}$	Thermal Resistance, Junction to Case (Note 1)	25	°C/W	
$R_{ heta JA}$	R _{0JA} Thermal Resistance, Junction to Ambient (Note 1a)		°C/W	

ELECTRICAL CHARACTERISTICS ($T_J = 25^{\circ}C$ unless otherwise noted)

Symbol	Parameter	Test Conditions		Тур	Max	Unit
Off Charact	eristics		•		•	
BV _{DSS}	Drain to Source Breakdown Voltage	$I_D = 250 \mu A, V_{GS} = 0 V$	40			V
$\Delta BV_{\mathtt{DSS}} \ \Delta T_{\mathtt{J}}$	Breakdown Voltage Temperature Coefficient	I _D = 250 μ A, referenced to 25°C		31		mV/°C
I _{DSS}	Zero Gate Voltage Drain Current	V _{DS} = 32 V, V _{GS} = 0 V			1	μΑ
I _{GSS}	Gate to Source Leakage Current	$V_{GS} = \pm 20 \text{ V}, V_{DS} = 0 \text{ V}$			±10	μΑ
On Charact	eristics					
VGS(th)	Gate to Source Threshold Voltage	$V_{GS} = V_{DS}, I_{D} = 250 \mu A$	1.0	1.8	3.0	V
$\Delta VGS(th) \ \Delta T_J$	Gate to Source Threshold Voltage Temperature Coefficient	I _D = 250 μA, referenced to 25°C		-6		mV/°C
r _{DS(on)}	Static Drain to Source On Resistance	V _{GS} = 10 V, I _D = 18.6 A		3.9	4.5	mΩ
		$V_{GS} = 4.5 \text{ V}, I_D = 14.9 \text{ A}$		4.6	6.0]
		V _{GS} = 10 V, I _D = 18.6 A, T _J = 125°C		5.9	7.0	
9FS	Forward Transconductance	$V_{DS} = 5 \text{ V}, I_{D} = 18.6 \text{ A}$		83		S
Dynamic Cl	haracteristics					
Ciss	Input Capacitance	V _{DS} = 20 V, V _{GS} = 0 V, f = 1 MHz		5665	7535	pF
Coss	Output Capacitance			650	865	pF
Crss	Reverse Transfer Capacitance			445	670	pF
R _q	Gate Resistance			1.2		Ω

ELECTRICAL CHARACTERISTICS (T_J = 25°C unless otherwise noted) (continued)

Symbol	Parameter	Test Conditions		Min	Тур	Max	Unit		
Switching Characteristics									
td(on)	Turn-On Delay Time	$V_{DD} = 20 \text{ V}, I_{D} = 18.6 \text{ A}, V_{GS} = 10 \text{ V},$ $R_{GEN} = 6 \Omega$			18	32	ns		
t _r					13	23	ns		
td(off)	Turn-Off Delay Time				57	103	ns		
t _f	Fall Time				11	20	ns		
Q_g	Total Gate Charge	V _{GS} = 0 V to 10 V	V = 20 V		103	144	nC		
Q_g	Total Gate Charge	V _{GS} = 0 V to 5 V	$V_{DD} = 20 \text{ V},$ $I_{D} = 18.6 \text{ A}$		54	76	nC		
Qgs	Gate to Source Charge		,		16		nC		
Qgd	Gate to Drain "Miller" Charge				19		nC		
Drain-Source Diode Characteristics									

Vsp	Source to Drain Diode Forward Voltage	$V_{GS} = 0 \text{ V}, I_{S} = 18.6 \text{ A}$	0.8	1.2	V
100	Joans to Fram Flour Formand Formage	V _{GS} = 0 V, I _S = 2.1 A	0.7	1.2	
trr	Reverse Recovery Time	I _F = 18.6 A, di/dt = 100 A/μs	33	53	ns
Qrr	Reverse Recovery Charge	,, 1010 / 1, 4, 4, 100 / 1, 100	21	34	nC

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

NOTES:

1. R_{0JA} is determined with the device mounted on a 1 in² pad 2 oz copper pad on a 1.5 x 1.5 in. board of FR-4 material. R_{0JC} is guaranteed by design while $R_{\theta CA}$ is determined by the user's board design.



a.) 50°C/W when mounted on a 1 in² pad of 2 oz copper



b.) 125°C/W when mounted on a minimum pad

- 2. Pulse Test: Pulse Width < 300 μ s, Duty cycle < 2.0%. 3. The diode connected between the gate and source servers only as protection against ESD. No gate overvoltage rating is implied. 4. Starting $T_J = 25^{\circ}C$, L = 3 mH, $I_{AS} = 20$ A, $V_{DD} = 40$ V, $V_{GS} = 10$ V.

TYPICAL CHARACTERISTICS

(T_J = 25°C unless otherwise noted)

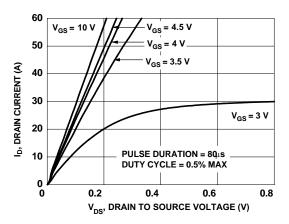


Figure 1. On-Region Characteristics

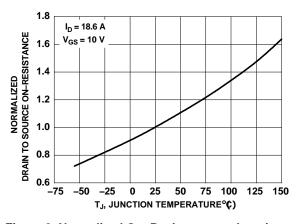


Figure 3. Normalized On–Resistance vs Junction Temperature

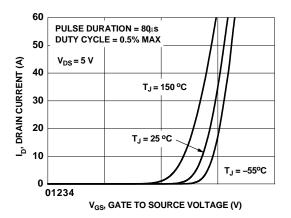


Figure 5. Transfer Characteristics

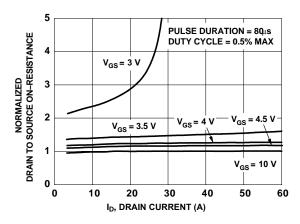


Figure 2. Normalized On-Resistance vs Drain Current and Gate Voltage

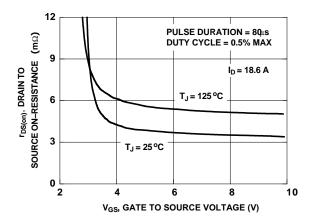


Figure 4. On-Resistance vs Gate to Source Voltage

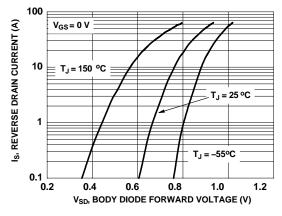


Figure 6. Source to Drain Diode Forward Voltage vs Source Current

TYPICAL CHARACTERISTICS

 $(T_J = 25^{\circ}C \text{ unless otherwise noted})$

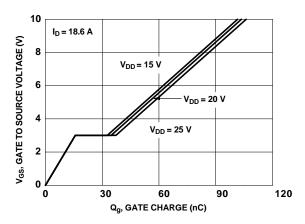


Figure 7. Gate Charge Characteristics

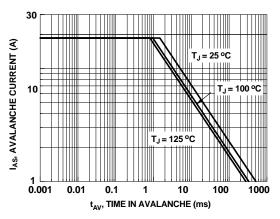


Figure 9. Unclamped Inductive Switching Capability

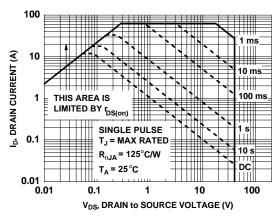


Figure 11. Forward Bias Safe Operating Area

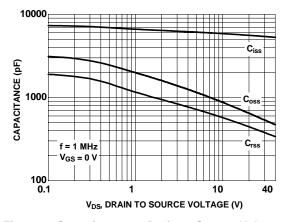


Figure 8. Capacitance vs Drain to Source Voltage

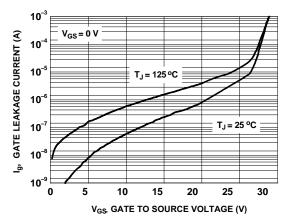


Figure 10. I_{GSS} vs V_{GS}

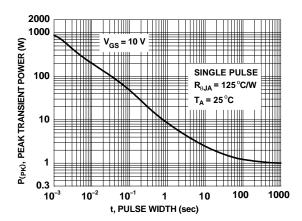


Figure 12. Single Pulse Maximum Power Dissipation

TYPICAL CHARACTERISTICS

 $(T_J = 25^{\circ}C \text{ unless otherwise noted})$

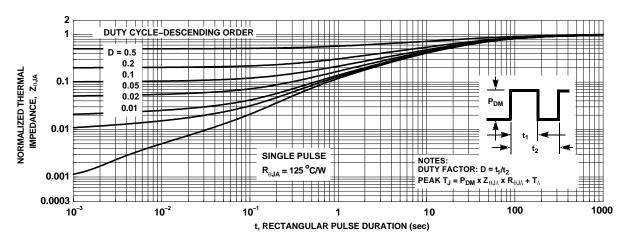
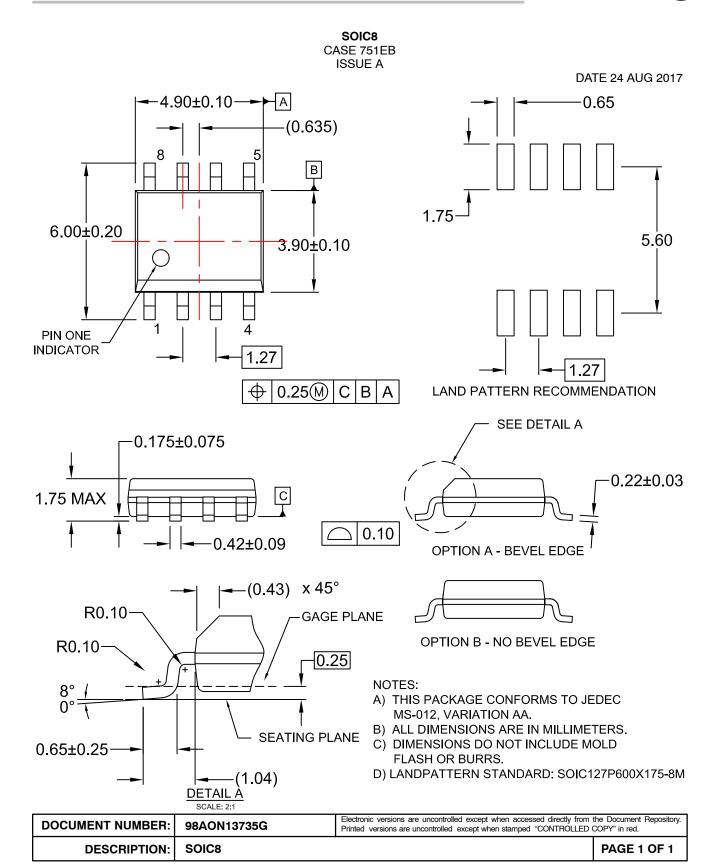


Figure 13. Transient Thermal Response Curve

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